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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
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10/539,662

06/14/2005

Atsushi Ogawa

83363.0012

6654

26021 7590 05/15/2009  
HOGAN & HARTSON L.L.P.  
1999 AVENUE OF THE STARS  
SUITE 1400  
LOS ANGELES, CA 90067

EXAMINER

YABUT, DIANE D

ART UNIT

PAPER NUMBER

3734

MAIL DATE

DELIVERY MODE

05/15/2009

PAPER

**Please find below and/or attached an Office communication concerning this application or proceeding.**

The time period for reply, if any, is set in the attached communication.

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APPLICATION NO./ CONTROL NO.	FILING DATE	FIRST NAMED INVENTOR / PATENT IN REEXAMINATION	ATTORNEY DOCKET NO.
10539662	6/14/2005	OGAWA ET AL.	83363.0012

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**EXAMINER**

DIANE YABUT

ART UNIT	PAPER
3734	20090513

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**Commissioner for Patents**

**(9) Grounds of Rejection**

The following ground(s) of rejection are applicable to the appealed claims:

**NEW GROUND(S) OF REJECTION**

The appellant's statement of the grounds of rejection to be reviewed on appeal is correct. However, the new grounds of rejection is directed to the Teoh et al. reference wherein instead of the single closed loop being characterized by element 108 which is directly fixed to rounded head portion 107 in Figures 2C-2D, the single closed loop is now characterized by element 170 which is directly fixed to rounded head portion 182.

/Todd E Manahan/  
Supervisory Patent Examiner, Art Unit 3734

/Diane Yabut/  
Examiner, Art Unit 3734